Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from,Europe,America and south Asia,supplying obsolete and hard-to-find components to meet their specific needs.

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EPC2103 – Enhancement-Mode GaN Power Transistor Half-Bridge

V_{DS}, 80 V

$R_{DS(on)}$, 5.5 mΩ

I_D, 30 A

EFFICIENT POWER CONVERSION

RoHS Halogen-Free

Gallium Nitride's exceptionally high electron mobility and low temperature coefficient allows very low $R_{DS(on)}$, while its lateral device structure and majority carrier diode provide exceptionally low Q_G and zero Q_{RR}. The end result is a device that can handle tasks where very high switching frequency, and low on-time are beneficial as well as those where on-state losses dominate.

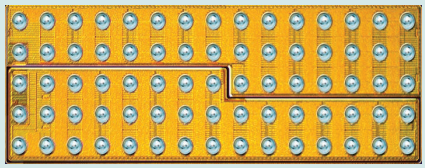
Maximum Ratings

DEVICE	PARAMETER		VALUE	UNIT
Q1 & Q2	V_{DS}	Drain-to-Source Voltage (Continuous)	80	V
		Drain-to-Source Voltage (up to 10,000 5 ms pulses at 150°C)	96	
	I_D	Continuous (T_A = 25°C, $R_{\theta JA}$ = 13°C/W)	30	A
		Pulsed (25°C, T_{PULSE} = 300 µs)	195	
	V_{GS}	Gate-to-Source Voltage	6	V
		Gate-to-Source Voltage	-4	
	T_J	Operating Temperature	–40 to 150	°C
	T_{STG}	Storage Temperature	–40 to 150	

Thermal Characteristics

PARAMETER		TYP	UNIT
$R_{\theta JC}$	Thermal Resistance, Junction to Case	0.3	°C/W
$R_{\theta JB}$	Thermal Resistance, Junction to Board	2.2	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1)	42	

Note 1: $R_{\theta JA}$ is determined with the device mounted on one square inch of copper pad, single layer 2 oz copper on FR4 board. See http://epc-co.com/epc/documents/product-training/Appnote_Thermal_Performance_of_eGaN_FETs.pdf for details



EPC2103 eGaN® ICs are supplied only in passivated die form with solder bumps
Die Size: 6.05 mm x 2.3 mm

Applications

- High Frequency DC-DC
- Motor Drive

Benefits

- Ultra High Efficiency
- High Frequency Operation
- High Density Footprint

www.epc-co.com/epc/Products/eGaNFETsandICs/EPC2103.aspx

Static Characteristics

DEVICE	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
Q1 & Q2	BV_{DSS}	Drain-to-Source Voltage	V_{GS} = 0 V, I_D = 0.5 mA	80			V
	I_{DSS}	Drain-Source Leakage	V_{DS} = 64 V, V_{GS} = 0 V		0.007	0.4	mA
	I_{GSS}	Gate-to-Source Forward Leakage	V_{GS} = 5 V		0.013	6.5	mA
		Gate-to-Source Reverse Leakage	V_{GS} = -4 V		0.007	0.4	mA
	$V_{GS(TH)}$	Gate Threshold Voltage	V_{DS} = V_{GS}, I_D = 7 mA	0.8	1.3	2.5	V
	$R_{DS(on)}$	Drain-Source On Resistance	V_{GS} = 5 V, I_D = 20 A		4	5.5	mΩ
	V_{SD}	Source-Drain Forward Voltage	I_S = 0.5 A, V_{GS} = 0 V		1.8		V

Dynamic Characteristics							
DEVICE	**PARAMETER**		**TEST CONDITIONS**	**MIN**	**TYP**	**MAX**	**UNIT**
Q1	C_{ISS}	Input Capacitance	V_{DS} = 40 V, V_{GS} = 0 V		730	880	pF
	C_{RSS}	Reverse Transfer Capacitance			7		
	C_{OSS}	Output Capacitance			445	670	
	$C_{OSS(ER)}$	Effective Output Capacitance, Energy Related (Note 2)	V_{DS} = 0 to 40 V, V_{GS} = 0 V		573		
	$C_{OSS(TR)}$	Effective Output Capacitance, Time Related (Note 3)			733		
	Q_G	Total Gate Charge	V_{DS} = 40 V, V_{GS} = 5 V, I_D = 20 A		6.5	8	nC
	Q_{GS}	Gate-to-Source Charge	V_{DS} = 40 V, I_D = 20 A		2.2		
	Q_{GD}	Gate-to-Drain Charge			1.1		
	$Q_{G(TH)}$	Gate Charge at Threshold			1.5		
	Q_{OSS}	Output Charge	V_{DS} = 40 V, V_{GS} = 0 V		30	45	
	Q_{RR}	Source-Drain Recovery Charge			0		
Q2	C_{ISS}	Input Capacitance	V_{DS} = 40 V, V_{GS} = 0 V		730	880	pF
	C_{RSS}	Reverse Transfer Capacitance			7		
	C_{OSS}	Output Capacitance			525	790	
	$C_{OSS(ER)}$	Effective Output Capacitance, Energy Related (Note 2)	V_{DS} = 0 to 40 V, V_{GS} = 0 V		668		
	$C_{OSS(TR)}$	Effective Output Capacitance, Time Related (Note 3)			855		
	Q_G	Total Gate Charge	V_{DS} = 40 V, V_{GS} = 5 V, I_D = 20 A		6.5	8	nC
	Q_{GS}	Gate-to-Source Charge	V_{DS} = 40 V, I_D = 20 A		2.2		
	Q_{GD}	Gate-to-Drain Charge			1.1		
	$Q_{G(TH)}$	Gate Charge at Threshold			1.5		
	Q_{OSS}	Output Charge	V_{DS} = 40 V, V_{GS} = 0 V		34	51	
	Q_{RR}	Source-Drain Recovery Charge			0		

Note 2: $C_{OSS(ER)}$ is a fixed capacitance that gives the same stored energy as C_{OSS} while V_{DS} is rising from 0 to 50% BV_{DSS}.
Note 3: $C_{OSS(TR)}$ is a fixed capacitance that gives the same charging time as C_{OSS} while V_{DS} is rising from 0 to 50% BV_{DSS}.

Figure 1 (Q1 & Q2): Typical Output Characteristics at 25°C

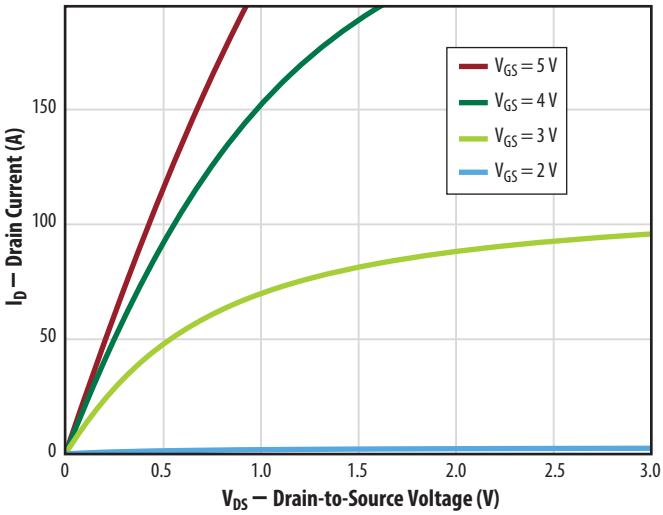


Figure 2 (Q1 & Q2): Transfer Characteristics

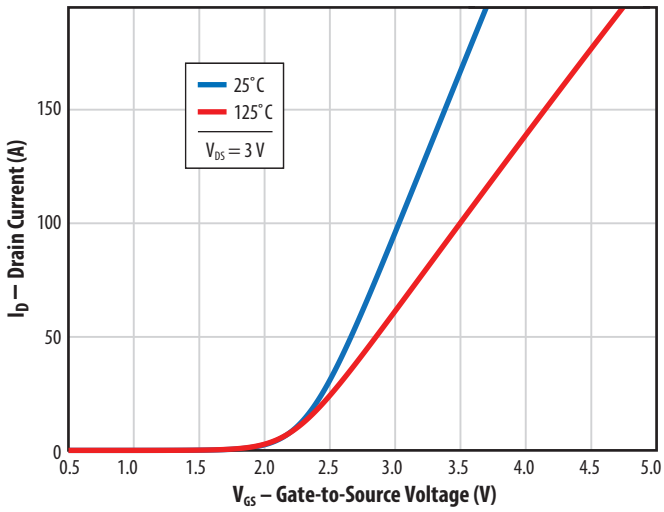


Figure 3 (Q1 & Q2): $R_{DS(on)}$ vs. V_{GS} for Various Drain Currents

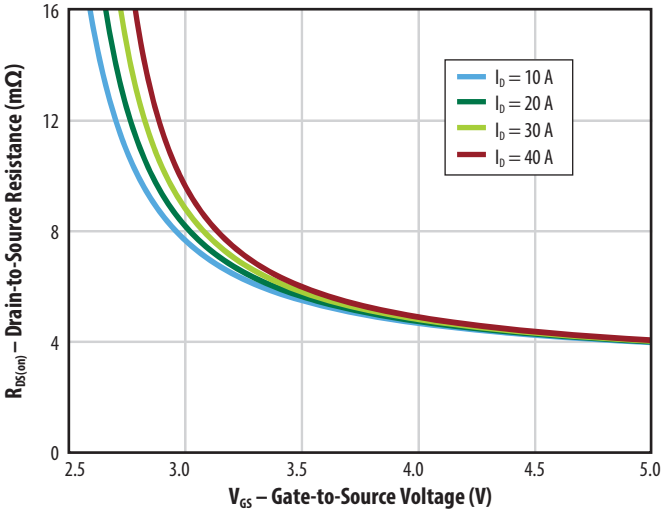


Figure 4 (Q1 & Q2): $R_{DS(on)}$ vs. V_{GS} for Various Temperatures

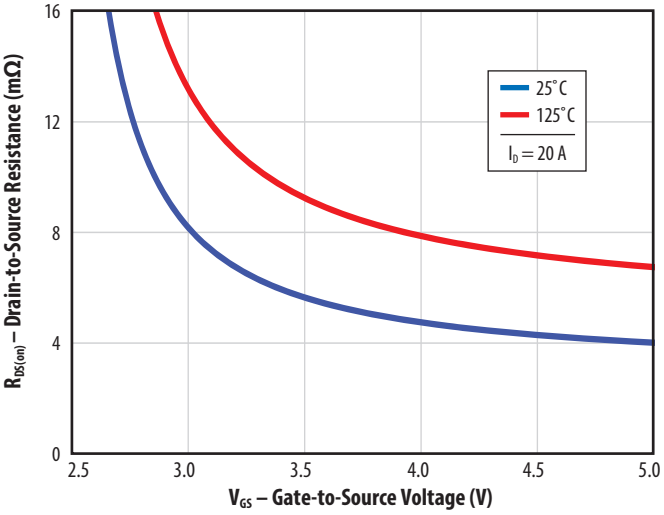


Figure 5a (Q1): Capacitance (Linear Scale)

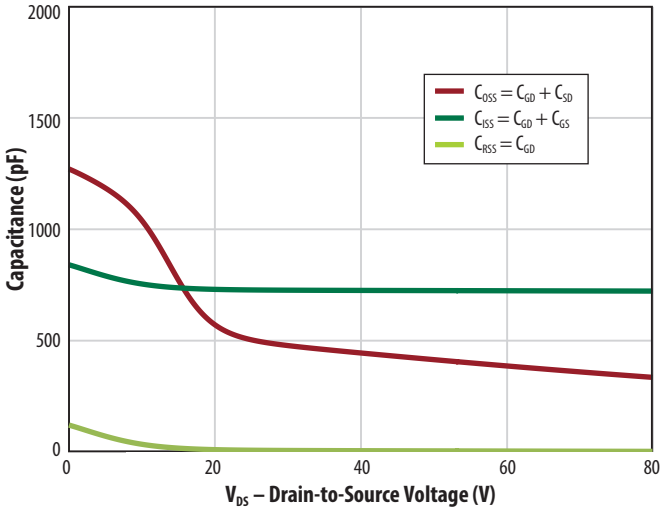


Figure 5b (Q1): Capacitance (Log Scale)

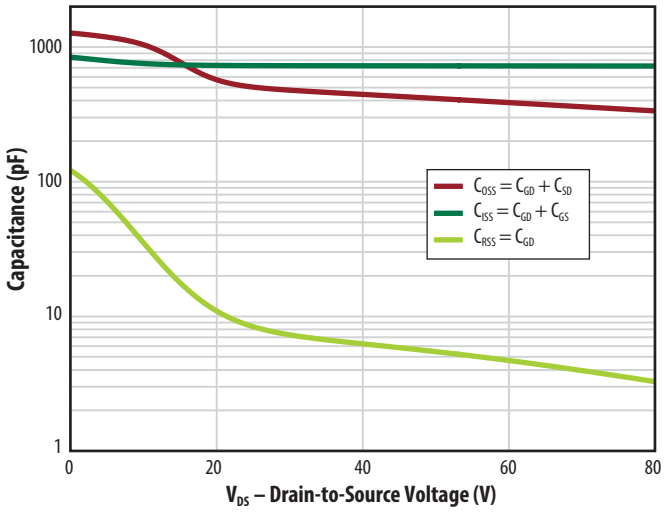


Figure 5c (Q2): Capacitance (Linear Scale)

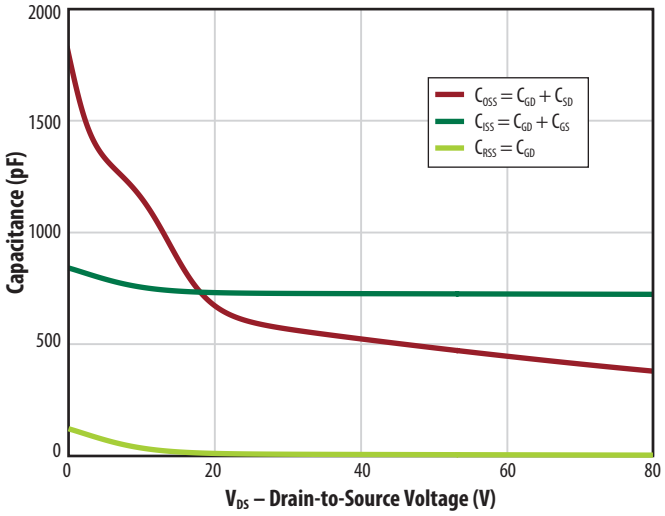


Figure 5d (Q2): Capacitance (Log Scale)

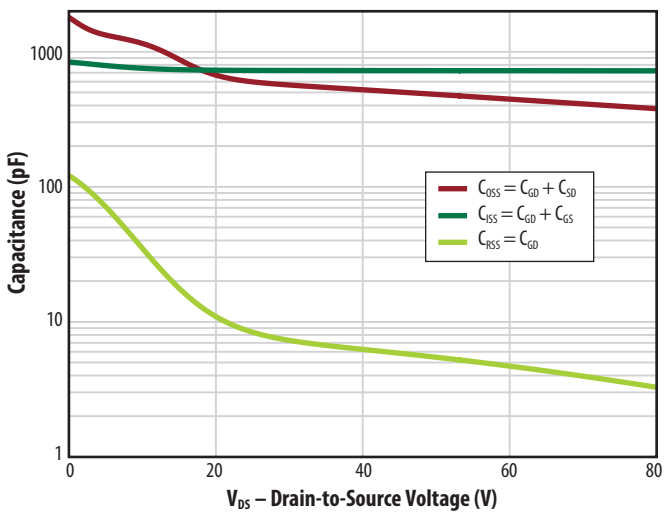


Figure 6a (Q1): Output Charge and C_{OSS} Stored Energy

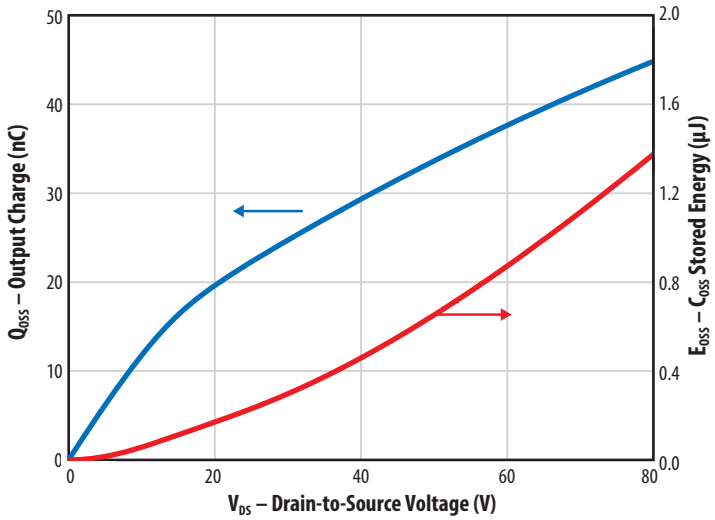


Figure 6b (Q2): Output Charge and C_{OSS} Stored Energy

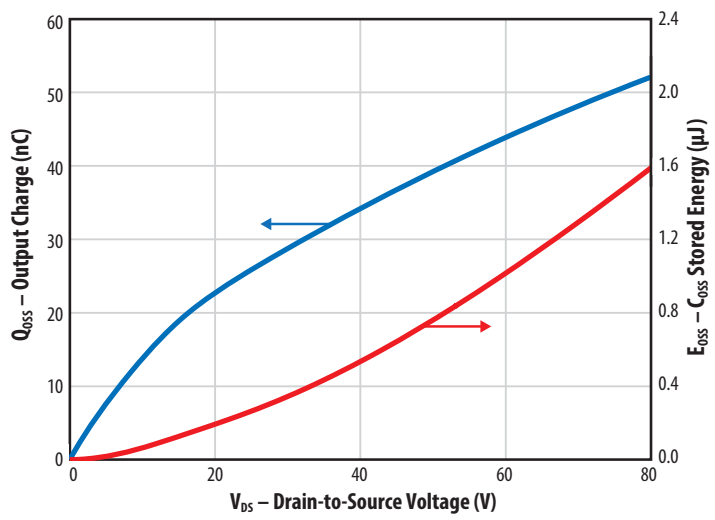


Figure 7 (Q1 & Q2): Gate Charge

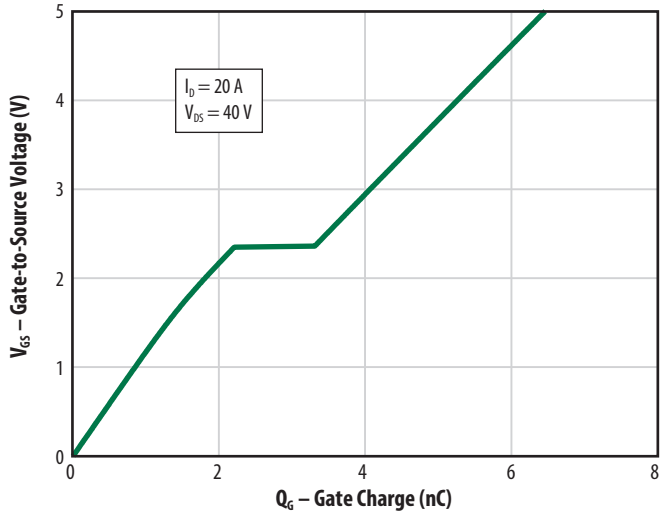


Figure 8 (Q1 & Q2): Reverse Drain-Source Characteristics

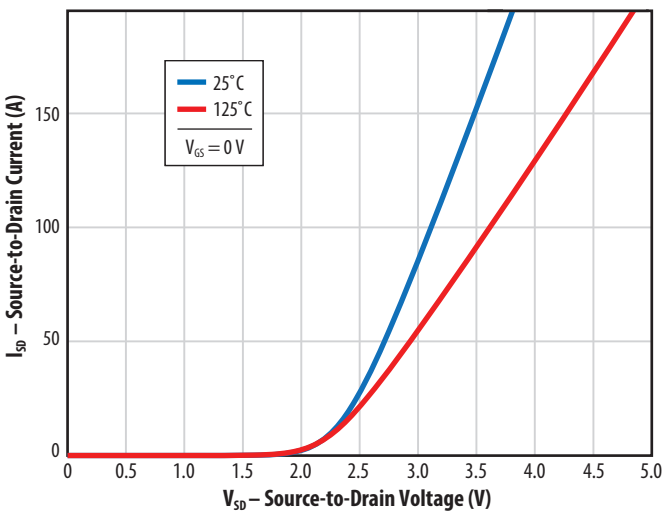


Figure 9 (Q1 & Q2):
Normalized On-State Resistance vs. Temperature

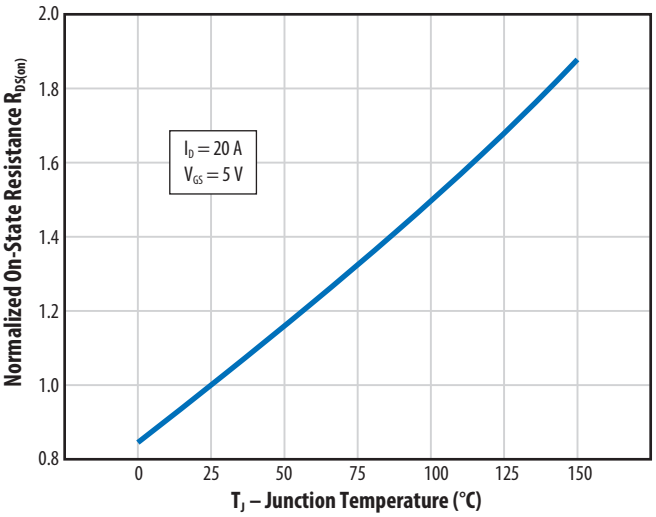


Figure 10 (Q1 & Q2):
Normalized Threshold Voltage vs. Temperature

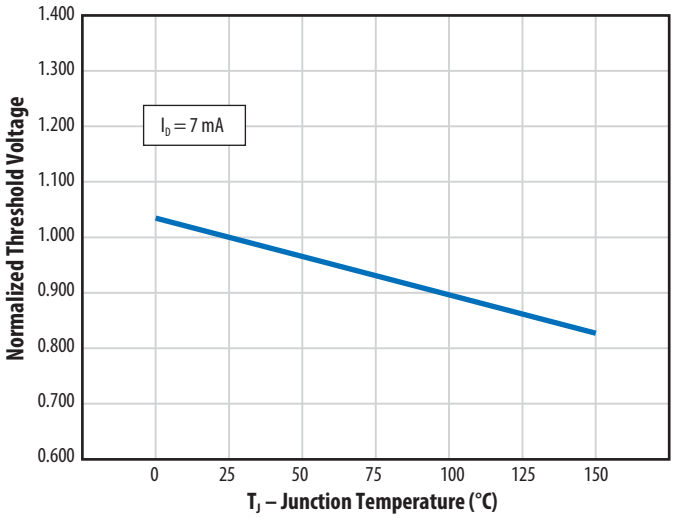


Figure 11a
Transient Thermal Response Curves

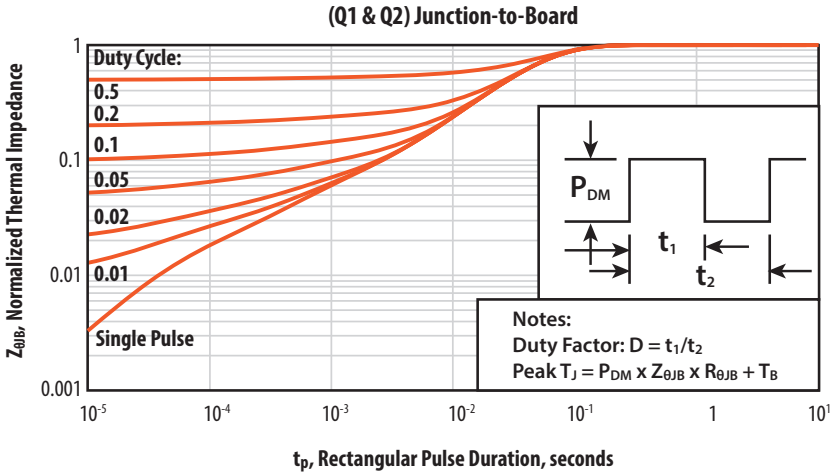


Figure 11b
Transient Thermal Response Curves

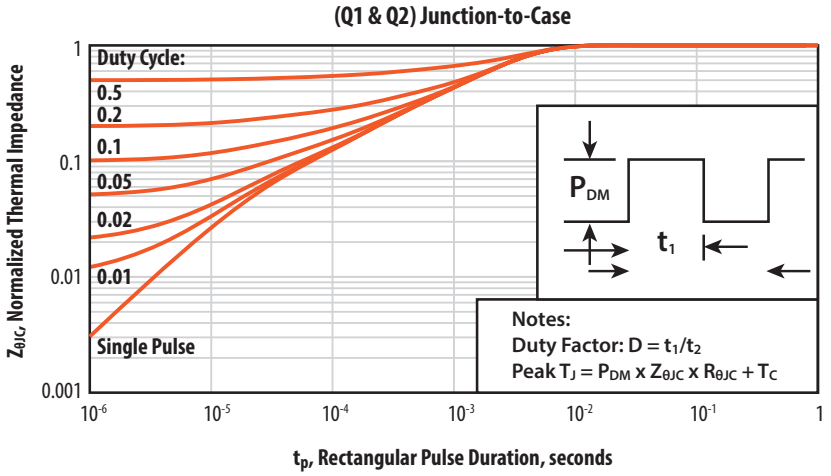
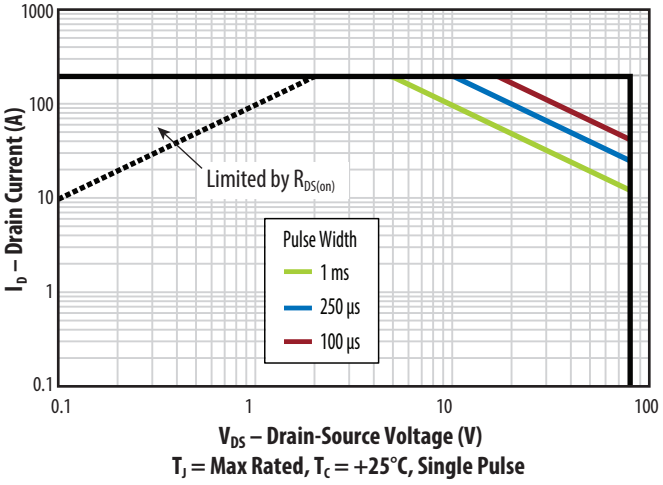
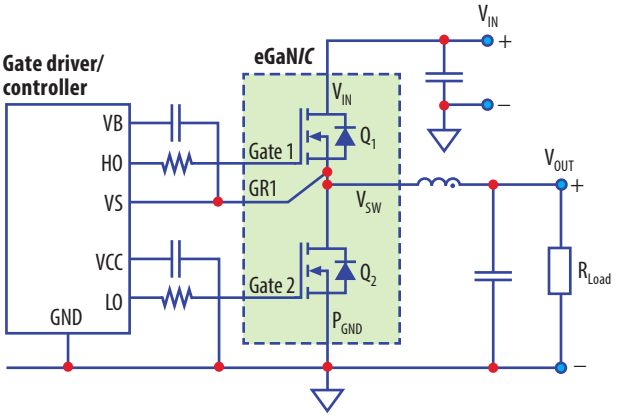


Figure 12 (Q1 & Q2): Safe Operating Area



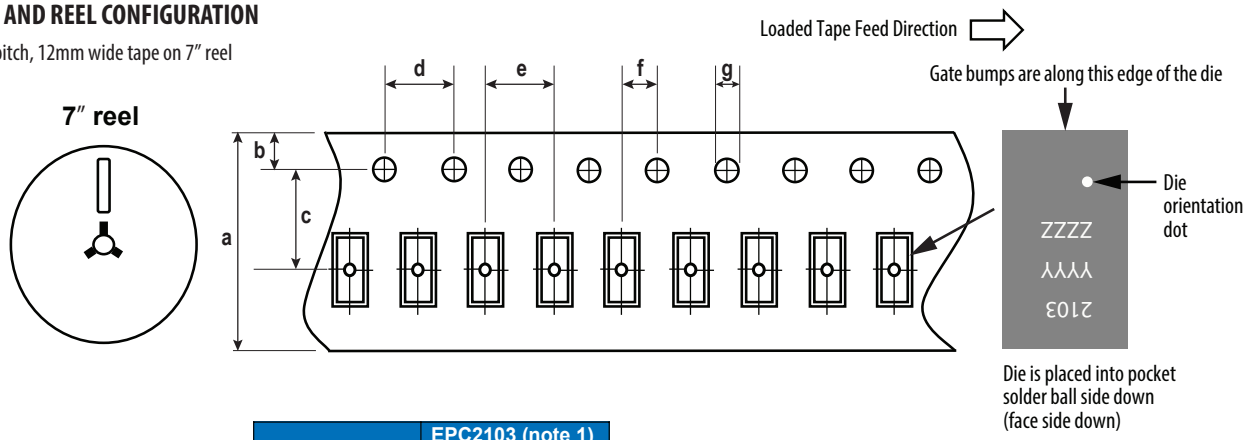
T_J = Max Rated, T_C = +25°C, Single Pulse

Figure 13: Typical Application Circuit



TAPE AND REEL CONFIGURATION

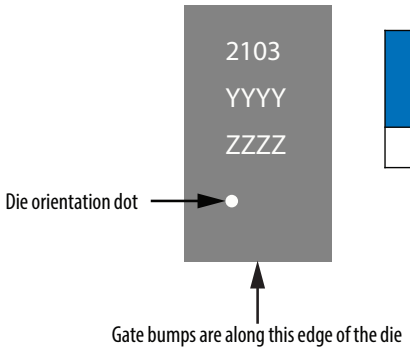
4mm pitch, 12mm wide tape on 7″ reel



	EPC2103 (note 1)		
Dimension (mm)	target	min	max
a	12.00	11.70	12.30
b	1.75	1.65	1.85
c (see note)	5.50	5.45	5.55
d	4.00	3.90	4.10
e	4.00	3.90	4.10
f (see note)	2.00	1.95	2.05
g	1.50	1.50	1.60

Note 1: MSL 1 (moisture sensitivity level 1) classified according to IPC/JEDEC industry standard.
Note 2: Pocket position is relative to the sprocket hole measured as true position of the pocket, not the pocket hole.

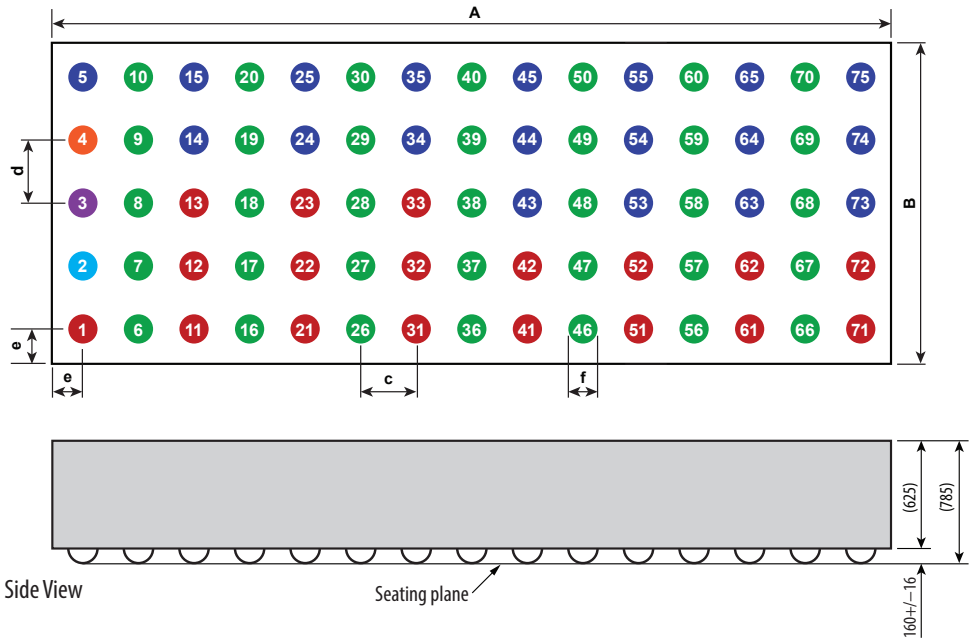
DIE MARKINGS



Part Number	Laser Markings		
	Part # Marking Line 1	Lot_Date Code Marking Line 2	Lot_Date Code Marking Line 3
EPC2103	2103	YYYY	ZZZZ

DIE OUTLINE

Solder Bump View



DIM	MIN	Nominal	MAX
A	6020	6050	6080
B	2270	2300	2330
c	400	400	400
d	450	450	450
e	210	225	240
f	187	208	229

Pad 2 is Gate 1 (high side); Pad 3 is HS Gate Return; Pad 4 is G2;

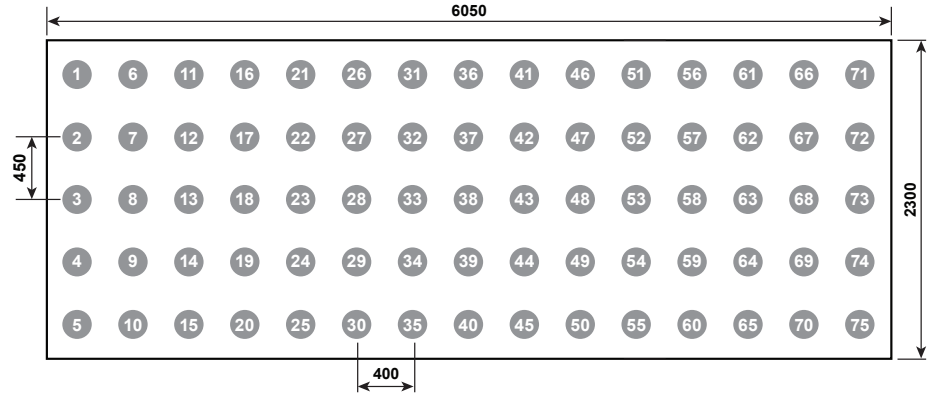
Pads 1, 11, 12, 13, 21, 22, 23, 31, 32, 33, 41, 42, 51, 52, 61, 62, 71, 72 are V_{IN};

Pads 5, 14, 15, 24, 25, 34, 35, 43, 44, 45, 53, 54, 55, 63, 64, 65, 73, 74, 75 Ground;

Pads 6, 7, 8, 9, 10, 16, 17, 18, 19, 20, 26, 27, 28, 29, 30, 36, 37, 38, 39, 40, 46, 47, 48, 49, 50, 56, 57, 58, 59, 60, 66, 67, 68, 69, 70 are Switch Node

RECOMMENDED LAND PATTERN

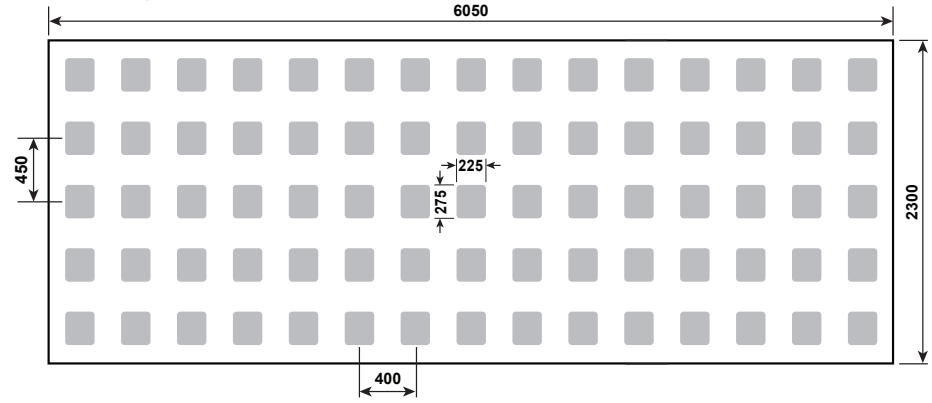
(measurements in µm)



The land pattern is solder mask defined. Suggest SMD Pads at 200 +20/–10 µm. 190 µm minimum.

RECOMMENDED STENCIL DRAWING

(measurements in µm)



Recommended stencil should be 4 mil (100 µm) thick, must be laser cut, openings per drawing.

Intended for use with SAC305 Type 4 solder, reference 88.5% metals content.

Additional assembly resources available at: http://epc-co.com/epc/DesignSupport/AssemblyBasics.aspx